## General Description

The MAX1086-MAX1089 are low-cost, micropower, serial output 10-bit analog-to-digital converters (ADCs) available in a tiny 8-pin SOT23. The MAX1086/MAX1088 operate with a single +5 V supply. The MAX1087/MAX1089 operate with a single +3 V supply. The devices feature a successive-approximation ADC, automatic shutdown, fast wake-up ( $1.4 \mu \mathrm{~s}$ ), and a high-speed 3-wire interface. Power consumption is only 0.5 mW (VDD $=+2.7 \mathrm{~V}$ ) at the maximum sampling rate of 150 ksps . AutoShutdown ${ }^{\text {TM }}(0.1 \mu \mathrm{~A})$ between conversions results in reduced power consumption at slower throughput rates. The MAX1086/MAX1087 provide 2-channel, singleended operation and accept input signals from 0 to VREF. The MAX1088/MAX1089 accept true-differential inputs ranging from 0 to Vref. Data is accessed using an external clock through the 3-wire SPI ${ }^{\text {TM }}$, QSPI ${ }^{\text {TM }}$, and MICROWIRE ${ }^{\text {TM }}$-compatible serial interface. Excellent dynamic performance, low-power, ease of use, and small package size, make these converters ideal for portable battery-powered data acquisition applications, and for other applications that demand low power consumption and minimal space.

| Low Power Data Acquisition |
| :--- |
| Portable Temperature Monitors |
| Flowmeters |
| Touch Screens |

AutoShutdown is a trademark of Maxim Integrated Products. SPI and QSPI are trademarks of Motorola Inc.
MICROWIRE is a trademark of National Semiconductor Corp.

```
* Single-Supply Operation
    +3V (MAX1087/MAX1089)
    +5V (MAX1086/MAX1088)
* AutoShutdown Between Conversions
- Low Power
    200\muA at 150ksps
    130\muA at 100ksps
    65\muA at 50ksps
    13\muA at 10ksps
    1.5\mu\textrm{A}\mathrm{ at 1ksps}
    0.2\mu\textrm{A}\mathrm{ in Shutdown}
* True-Differential Track/Hold, 150kHz Sampling Rate
- Software-Configurable Unipolar/Bipolar
    Conversion (MAX1088/MAX1089 only)
- SPI, QSPI, MICROWIRE-Compatible Interface for
    DSPs and Processors
- Internal Conversion Clock
- 8-Pin SOT23 and 8-Pin TDFN Packages
```

                                    Ordering Information
    | PART | TEMP <br> RANGE | PIN- <br> PACKAGE | TOP <br> MARK |
| :--- | :--- | :--- | :---: |
| MAX1086EKA-T | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 8 SOT23 | AAEZ |
| MAX1086ETA +T | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 8 TDFN-EP* | AFQ |
| MAX1087EKA-T | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 8 SOT23 | AAEV |
| MAX1087ETA +T | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 8 TDFN-EP* | AFM |
| MAX1088EKA-T | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 8 SOT23 | AAFB |
| MAX1088ETA +T | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 8 TDFN-EP* | AFS |
| MAX1089EKA-T | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 8 SOT23 | AAEX |
| MAX1089ETA +T | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 8 TDFN-EP* | AFO |

*EP = Exposed pad.
+Denotes a lead(Pb)-free/RoHS-compliant package.
$T$ = Tape and reel.

Pin Configurations

## 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN

## ABSOLUTE MAXIMUM RATINGS

VDD to GND<br>CNVST, SCLK, DOUT to GND<br>$\qquad$<br>0.3 V to +6 V<br>REF AN1(AN ): ANA(ANA) GND $\quad .0 .3 \mathrm{~V}$ (VDD+0.3V<br>-0.3V to (VDD+0.3V<br>Maximum Current Into Any Pin ............................................. 50 mA Continuous Power Dissipation ( $\mathrm{T}_{\mathrm{A}}=+70^{\circ} \mathrm{C}$ )<br>8-Pin SOT23 (derate $9.70 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $\mathrm{T}_{\mathrm{A}}=+70^{\circ} \mathrm{C}$ )...... 777 mW<br>8-Pin TDFN (derate $18.2 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $\mathrm{T}_{\mathrm{A}}=+70^{\circ} \mathrm{C}$ ). .1454 .5 mW

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## ELECTRICAL CHARACTERISTICS

$\left(V_{D D}=+2.7 \mathrm{~V}\right.$ to $+3.6 \mathrm{~V}, \mathrm{~V}_{\text {REF }}=+2.5 \mathrm{~V}$ for MAX1087/MAX1089, or $\mathrm{VDD}=+4.75 \mathrm{~V}$ to +5.25 V , $\mathrm{V}_{\mathrm{REF}}=+4.096 \mathrm{~V}$ for MAX1086/MAX1088, $0.1 \mu \mathrm{~F}$ capacitor at REF, fSCLK $=8 \mathrm{MHz}$ ( $50 \%$ duty cycle), AIN- $=$ GND for MAX1088/MAX1089. $\mathrm{T}_{\mathrm{A}}=\mathrm{T}_{\mathrm{MIN}}$ to $\mathrm{T}_{\mathrm{MAX}}$, unless otherwise noted. Typical values at $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: |
| DC ACCURACY (Note 1) |  |  |  |  |  |
| Resolution |  |  | 10 |  | Bits |
| Relative Accuracy (Note 2) | INL |  |  | $\pm 1.0$ | LSB |
| Differential Nonlinearity | DNL | No missing codes over temperature |  | $\pm 1.0$ | LSB |
| Offset Error |  |  | $\pm 0.5$ | $\pm 1.0$ | LSB |
| Gain Error (Note 3) |  |  | $\pm 1.0$ | $\pm 2.0$ | LSB |
| Gain Temperature Coefficient |  |  | $\pm 0.8$ |  | ppm $/{ }^{\circ} \mathrm{C}$ |
| Channel-to-Channel Offset |  |  | $\pm 0.1$ |  | LSB |
| Channel-to-Channel Gain Matching |  |  | $\pm 0.1$ |  | LSB |
| Input Common-Mode Rejection | CMR | $\mathrm{V}_{\mathrm{CM}}=0 \mathrm{~V}$ to $\mathrm{V}_{\mathrm{DD}}$; zero scale input | $\pm 0.1$ |  | mV |
| DYNAMIC SPECIFICATIONS: (fin (sine-wave) $=10 \mathrm{kHz}, \mathrm{V}_{\mathrm{IN}}=4.096 \mathrm{Vp}-\mathrm{p}$ for MAX1086/MAX1088 or $\mathrm{V}_{\mathrm{IN}}=2.5 \mathrm{~V}$ PP for MAX1087/MAX1089, 150ksps, fSCLK $=8 \mathrm{MHz}$, AIN- = GND for MAX1088/MAX1089) |  |  |  |  |  |
| Signal to Noise Plus Distortion | SINAD |  | 61 |  | dB |
| Total Harmonic Distortion (up to the $5^{\text {th }}$ harmonic) | THD |  | -70 |  | dB |
| Spurious-Free Dynamic Range | SFDR |  | 70 |  | dB |
| Full-Power Bandwidth |  | -3dB point | 1 |  | MHz |
| Full-Linear Bandwidth |  | SINAD > 56dB | 100 |  | kHz |
| CONVERSION RATE |  |  |  |  |  |
| Conversion Time | tconv |  |  | 3.7 | $\mu \mathrm{s}$ |
| T/H Acquisition Time | tACQ |  |  | 1.4 | $\mu \mathrm{s}$ |
| Aperture Delay |  |  | 30 |  | ns |
| Aperture Jitter |  |  | <50 |  | ps |
| Maximum Serial Clock Frequency | fsclk |  | 8 |  | MHz |
| Duty Cycle |  |  | 30 | 70 | \% |

## 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN

## ELECTRICAL CHARACTERISTICS (continued)

$\left(V_{D D}=+2.7 \mathrm{~V}\right.$ to +3.6 V , $\mathrm{V}_{\text {REF }}=+2.5 \mathrm{~V}$ for MAX1087/MAX1089, or $\mathrm{VDD}=+4.75 \mathrm{~V}$ to +5.25 V , $\mathrm{V}_{\mathrm{REF}}=+4.096 \mathrm{~V}$ for MAX1086/MAX1088, $0.1 \mu \mathrm{~F}$ capacitor at REF, fscLK $=8 \mathrm{MHz}\left(50 \%\right.$ duty cycle), AIN- $=$ GND for MAX1088/MAX1089. $\mathrm{T}_{\mathrm{A}}=\mathrm{T}_{\mathrm{MIN}}$ to $\mathrm{T}_{\mathrm{MAX}}$, unless otherwise noted. Typical values at $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$.)

| PARAMETER | SYMBOL | CONDITIONS |  | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG INPUT |  |  |  |  |  |  |  |
| Input Voltage Range (Note 4) |  | Unipolar |  | 0 |  | $\mathrm{V}_{\text {REF }}$ | V |
|  |  | Bipolar |  | -VREF /2 |  | $V_{\text {REF/2 }}$ |  |
| Input Leakage Current |  | Channel not selected or conversion stopped |  |  | $\pm 0.01$ | $\pm 1$ | $\mu \mathrm{A}$ |
| Input Capacitance |  |  |  | 34 |  |  | pF |
| EXTERNAL REFERENCE INPUT |  |  |  |  |  |  |  |
| Input Voltage Range | VREF |  |  | 1.0 |  | $\begin{gathered} \\ \\ V_{D D} \\ + \\ +50 \mathrm{mV} \end{gathered}$ | V |
| Input Current | IREF | $\mathrm{V}_{\text {REF }}=+2.5 \mathrm{~V}$ at 150ksps |  |  | 16 | 30 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\text {REF }}=+4.096 \mathrm{~V}$ at 150ksps |  |  | 26 | 45 |  |
|  |  | Acquisition/Between conversions |  |  | $\pm 0.01$ | $\pm 1$ |  |
| DIGITAL INPUTS/OUTPUTS (SCLK, CNVST, DOUT) |  |  |  |  |  |  |  |
| Input Low Voltage | $\mathrm{V}_{\text {IL }}$ |  |  |  |  | 0.8 | V |
| Input High Voltage | $\mathrm{V}_{\mathrm{IH}}$ |  |  | $\mathrm{V}_{\mathrm{DD}}-1$ |  |  | V |
| Input Leakage Current | IL |  |  |  |  | $\pm 0.1$ | $\mu \mathrm{A}$ |
| Input Capacitance | CIN |  |  |  | 15 |  | pF |
| Output Low Voltage | VoL | ISINK $=2 \mathrm{~mA}$ |  |  |  | 0.4 | V |
|  |  | ISINK $=4 \mathrm{~mA}$ |  |  |  | 0.8 | V |
| Output High Voltage | VOH | ISOURCE $=1.5 \mathrm{~mA}$ |  | $\begin{aligned} & \hline V_{D D} \\ & -0.5 \end{aligned}$ |  |  | V |
| Three-State Leakage Current |  | CNVST = GND |  |  |  | $\pm 10$ | $\mu \mathrm{A}$ |
| Three-State Output Capacitance | Cout | CNVST = GND |  |  | 15 |  | pF |
| POWER REQUIREMENTS |  |  |  |  |  |  |  |
| Positive Supply Voltage | $V_{D D}$ | MAX1086/MAX1088 |  | 4.75 | 5.0 | 5.25 | V |
|  |  | MAX1087/MAX1089 |  | 2.7 | 3.0 | 3.6 |  |
| Positive Supply Current | IDD | $V_{D D}=+3 V$ | fSAMPLE $=150 \mathrm{ksps}$ |  | 245 | 350 | $\mu \mathrm{A}$ |
|  |  |  | fSAMPLE $=100 \mathrm{ksps}$ |  | 150 |  |  |
|  |  |  | fSAMPLE $=10 \mathrm{ksps}$ |  | 15 |  |  |
|  |  |  | fSAMPLE $=1 \mathrm{ksps}$ |  | 2 |  |  |
|  |  | $V_{D D}=+5 \mathrm{~V}$ | fSAMPLE $=150 \mathrm{ksps}$ |  | 320 | 400 |  |
|  |  |  | $\mathrm{f}_{\text {SAMPLE }}=100 \mathrm{ksps}$ |  | 215 |  |  |
|  |  |  | fSAMPLE $=10 \mathrm{ksps}$ |  | 22 |  |  |
|  |  |  | fSAMPLE $=1 \mathrm{ksps}$ |  | 2.5 |  |  |
|  |  | Shutdown |  |  | 0.2 | 5 |  |
| Positive Supply Rejection | PSR | $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V} \pm 5 \%$; full-scale input |  |  | $\pm 0.1$ | 1.0 | mV |
|  |  | $\mathrm{V}_{\mathrm{DD}}=+2.7 \mathrm{~V}$ to +3.6 V ; full-scale input |  |  | $\pm 0.1$ | $\pm 1.2$ |  |

## 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN

TIMING CHARACTERISTICS (Figures 1 and 2)
$\left(V_{D D}=+2.7 \mathrm{~V}\right.$ to +3.6 V , $\mathrm{V}_{\text {REF }}=+2.5 \mathrm{~V}$ for MAX1087/MAX1089, or $\mathrm{V}_{\mathrm{DD}}=+4.75 \mathrm{~V}$ to +5.25 V , $\mathrm{V}_{\mathrm{REF}}=+4.096 \mathrm{~V}$ for MAX1086/MAX1088, $0.1 \mu \mathrm{~F}$ capacitor at REF, fSCLK $=8 \mathrm{MHz}\left(50 \%\right.$ duty cycle); AIN- $=$ GND for MAX1088/MAX1089. $\mathrm{T}_{\mathrm{A}}=\mathrm{T}_{\mathrm{MIN}}$ to $\mathrm{T}_{\mathrm{MAX}}$, unless otherwise noted. Typical values at $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$.)

| PARAMETERS | SYMBOL | CONDITIONS | MIN | TYP | MAX |
| :--- | :---: | :--- | :---: | :---: | :---: |
| UNITS |  |  |  |  |  |
| SCLK Pulse Width High | tCH |  | 38 |  | ns |
| SCLK Pulse Width Low | tCL |  | 38 | ns |  |
| SCLK Fall to DOUT Transition | tDOT | CLOAD $=30 \mathrm{pF}$ |  | 60 | ns |
| SCLK Rise to DOUT Disable | tDOD | CLOAD $=30 \mathrm{pF}$ | 100 | 500 | ns |
| CNVST Rise to DOUT Enable | tDOE | CLOAD $=30 \mathrm{pF}$ |  | 80 | ns |
| CNVST Fall to MSB Valid | tDOV | CLOAD $=30 \mathrm{pF}$ |  | 3.7 | $\mu \mathrm{~s}$ |
| CNVST Pulse Width | tCSW |  | 30 | ns |  |

Note 1: Unipolar input.
Note 2: Relative accuracy is the deviation of the analog value at any code from its theoretical value after offset and gain errors have been removed.
Note 3: Offset nulled.
Note 4: The absolute input range for the analog inputs is from GND to VDD.


Figure 1. Detailed Serial-Interface Timing Sequence

a) HIGH -Z TO $\mathrm{V}_{\text {OH, }}, \mathrm{V}_{\text {OL }} \mathrm{TO} \mathrm{V}_{\text {OH, }}$ AND $\mathrm{V}_{\text {OH }}$ TO $\mathrm{HIGH}-Z$

a) HIGH -Z TO $V_{O L}, V_{O H} T O V_{O L}$, AND $V_{O L}$ TO HIGH $-Z$

Figure 2. Load Circuits for Enable/Disable Times

## 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN

Typical Operating Characteristics
$\left(V_{D D}=+3.0 \mathrm{~V}, \mathrm{~V}_{\text {REF }}=+2.5 \mathrm{~V}\right.$ for MAX1087/MAX1089 or $\mathrm{V}_{\mathrm{DD}}=+5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{REF}}=+4.096 \mathrm{~V}$ for MAX1086/MAX1088, $0.1 \mu \mathrm{~F}$ capacitor at REF, fsclk $=8 \mathrm{MHz},\left(50 \%\right.$ Duty Cycle), AIN- $=$ GND for MAX1088/1089, $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$, unless otherwise noted. $)$


## 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN

$\left(V_{D D}=3.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{REF}}=2.5 \mathrm{~V}\right.$ for MAX1087/MAX1089 or $\mathrm{V}_{\mathrm{DD}}=5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{REF}}=+4.096 \mathrm{~V}$ for MAX1086MAX1088, $0.1 \mu \mathrm{~F}$ capacitor at REF,
fsclk $=8 \mathrm{MHz},\left(50 \%\right.$ Duty Cycle), AIN- $=$ GND for MAX1088/89, $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$, unless otherwise noted. )


# 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN 

| PIN | NAME |  | FUNCTION |
| :---: | :---: | :---: | :---: |
|  | MAX1086 MAX1087 | MAX1088 MAX1089 |  |
| 1 | $V_{D D}$ | $V_{D D}$ | Positive Supply Voltage. +2.7V to +3.6V (MAX1087/MAX1089); +4.75V to +5.25V (MAX1086/MAX1088). Bypass with a $0.1 \mu \mathrm{~F}$ capacitor to GND. |
| 2 | AIN1 | AIN+ | Analog Input Channel 1 (MAX1086/MAX1087) or Positive Analog Input (MAX1088/MAX1089) |
| 3 | AIN2 | AIN- | Analog Input Channel 2 (MAX1086/MAX1087) or Negative Analog Input (MAX1088/MAX1089) |
| 4 | GND | GND | Ground |
| 5 | REF | REF | External Reference Voltage Input. Sets the analog voltage range. Bypass with a $0.1 \mu \mathrm{~F}$ capacitor to GND. |
| 6 | CNVST | CNVST | Conversion Start. A rising edge powers-up the IC and places it in track mode. At the falling edge of CNVST, the device enters hold mode and begins conversion. CNVST also selects the input channel (MAX1086/MAX1087) or input polarity (MAX1088/MAX1089). |
| 7 | DOUT | DOUT | Serial Data Output. DOUT transitions the falling edge of SCLK. DOUT goes low at the start of a conversion and presents the MSB at the completion of a conversion. DOUT goes highimpedance once data has been fully clocked out. |
| 8 | SCLK | SCLK | Serial Clock Input. Clocks out data at DOUT MSB first. |
| - | EP | - | Exposed Pad (TDFN only). Connect the exposed pad to ground or leave unconnected. |

## Detailed Description

The MAX1086-MAX1089 analog-to-digital converters (ADCs) use a successive-approximation conversion (SAR) technique and an on-chip track-and-hold (T/H) structure to convert an analog signal into a 10-bit digital result.


Figure 3. Simplified Functional Diagram

The serial interface provides easy interfacing to microprocessors ( $\mu \mathrm{Ps}$ ). Figure 3 shows the simplified internal structure for the MAX1086/MAX1087 (2-channels, sin-gle-ended) and the MAX1088/MAX1089 (1-channel, true-differential).

## True-Differential Analog Input Track/Hold

The equivalent circuit of Figure 4 shows the MAX1086-MAX1089's input architecture which is composed of a $\mathrm{T} / \mathrm{H}$, input multiplexer, comparator, and switched-capacitor DAC. The T/H enters its tracking mode on the rising edge of CNVST. The positive input capacitor is connected to AIN1 or AIN2 (MAX1086/ MAX1087) or AIN+ (MAX1088/MAX1089). The negative input capacitor is connected to GND (MAX1086/ MAX1087) or AIN- (MAX1088/MAX1089). The T/H enters its hold mode on the falling edge of CNVST and the difference between the sampled positive and negative input voltages is converted. The time required for the T/H to acquire an input signal is determined by how quickly its input capacitance is charged. If the input signal's source impedance is high, the acquisition time lengthens, and CNVST must be held high for a longer period of time. The acquisition time, $\mathrm{t}_{\mathrm{ACQ}}$, is the maximum time needed for the signal to be acquired, plus the power-up time. It is calculated by the following equation:

$$
t_{A C Q}=7 \times(R S+R I N) \times 24 p F+t_{P W R}
$$

## 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN



Figure 4. Equivalent Input Circuit
where $\operatorname{RIN}=1.5 \mathrm{k} \Omega$, RS is the source impedance of the input signal, and tPWR $=1 \mu$ s is the power-up time of the device.
Note: tacQ is never less than $1.4 \mu \mathrm{~s}$ and any source impedance below $300 \Omega$ does not significantly affect the ADC's AC performance. A high impedance source can be accommodated either by lengthening tACQ or by placing a $1 \mu \mathrm{~F}$ capacitor between the positive and negative analog inputs.

## Selecting AIN1 or AIN2 (MAX1086/MAX1087)

Select between the MAX1086/MAX1087's two positive input channels using the CNVST pin. If AIN1 is desired (Figure 5a), drive CNVST high to power-up the ADC and place the T/H in track mode with AIN1 connected to the positive input capacitor. Hold CNVST high for tACQ to fully acquire the signal. Drive CNVST low to place the T/H in hold mode. The ADC will then perform a conversion and shutdown automatically. The MSB is available at DOUT after $3.7 \mu \mathrm{~s}$. Data can then be clocked out using SCLK. Be sure to clock out all 12 bits of data (the 10-bit result plus two sub-bits) before driving CNVST high for the next conversion. If all 12 bits of data are not clocked out before CNVST is driven high, AIN2 will be selected for the next conversion.
If AIN2 is desired (Figure 5b), drive CNVST high for at least 30 ns . Next, drive it low for at least 30 ns , and then high again. This will power-up the ADC and place the T/H in track mode with AIN2 connected to the positive input capacitor. Now hold CNVST high for taCQ to fully acquire the signal. Drive CNVST low to place the T/H in hold mode. The ADC will then perform a conversion and shutdown automatically. The MSB is available at

DOUT after 3.7 $\mathrm{\mu s}$. Data can then be clocked out using SCLK. If all 12 bits of data are not clocked out before CNVST is driven high, AIN2 will be selected for the next conversion.

## Selecting Unipolar or Bipolar Conversions

 (MAX1088/MAX1089)Initiate true-differential conversions with the MAX1088/MAX1089's unipolar and bipolar modes, using the CNVST pin. AIN+ and AIN- are sampled at the falling edge of CNVST. In unipolar mode, AIN+ can exceed AIN- by up to Vref. The output format is straight binary. In bipolar mode, either input can exceed the other by up to $V_{\text {REF }} / 2$. The output format is two's complement.
Note: In both modes, AIN+ and AIN- must not exceed VDD by more than 50 mV or be lower than GND by more than 50 mV .
If unipolar mode is desired (Figure 5a), drive CNVST high to power-up the ADC and place the T/H in track mode with AIN+ and AIN- connected to the input capacitors. Hold CNVST high for tACQ to fully acquire the signal. Drive CNVST low to place the T/H in hold mode. The ADC will then perform a conversion and shutdown automatically. The MSB is available at DOUT after $3.7 \mu \mathrm{~s}$. Data can then be clocked out using SCLK. Be sure to clock out all 12 bits (the 10-bit result plus two sub-bits) of data before driving CNVST high for the next conversion. If all 12 bits of data are not clocked out before CNVST is driven high, bipolar mode will be selected for the next conversion.
If bipolar mode is desired (Figure 5b), drive CNVST high for at least 30 ns. Next, drive it low for at least 30ns and then high again. This will place the T/H in track mode with AIN+ and AIN- connected to the input capacitors. Now hold CNVST high for tACQ to fully acquire the signal. Drive CNVST low to place the T/H in hold mode. The ADC will then perform a conversion and shutdown automatically. The MSB is available at DOUT after $3.7 \mu \mathrm{~s}$. Data can then be clocked out using SCLK. If all 12 bits of data are not clocked out before CNVST is driven high, bipolar mode will be selected for the next conversion.

## Input Bandwidth

The ADCs input tracking circuitry has a 1 MHz smallsignal bandwidth, so it is possible to digitize highspeed transient events and measure periodic signals with bandwidths exceeding the ADC's sampling rate by using undersampling techniques. To avoid high frequency signals being aliased into the frequency band of interest, anti-alias filtering is recommended.

## 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN



Figure 5a. Single Conversion AIN1 vs. GND (MAX1086/MAX1087), unipolar mode AIN+ vs. AIN- (MAX1088/MAX1089)


Figure 5b. Single Conversion AIN2 vs. GND (MAX1086/MAX1087), bipolar mode AIN+ vs. AIN- (MAX1088/MAX1089)

Analog Input Protection
Internal protection diodes which clamp the analog input to VDD and GND allow the analog input pins to swing from GND - 0.3 V to $\mathrm{V}_{\mathrm{DD}}+0.3 \mathrm{~V}$ without damage. Both inputs must not exceed VDD by more than 50 mV or be lower than GND by more than 50 mV for accurate conversions. If an off-channel analog input voltage exceeds the supplies, limit the input current to 2 mA .

Internal Clock
The MAX1086-MAX1089 operate from an internal oscillator, which is accurate within $10 \%$ of the 4 MHz specified clock rate. This results in a worse case conversion time of $3.7 \mu \mathrm{~s}$. The internal clock releases the system microprocessor from running the SAR conversion clock and allows the conversion results to be read back at the processor's convenience, at any clock rate from 0 to 8 MHz .

# 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN 

Figures 5 a and 5 b illustrate the conversion timing for the MAX1086-MAX1089. The 10-bit conversion result is output in MSB first format, followed by two sub-bits (S1 and SO). Data on DOUT transitions on the falling edge of SCLK. All 12-bits must be clocked out before CNVST transitions again. For the MAX1088/MAX1089, data is straight binary for unipolar mode and two's complement for bipolar mode. For the MAX1086/MAX1087, data is always straight binary.

## Applications Information

## Automatic Shutdown Mode

With CNVST low, the MAX1086-MAX1089 defaults to an AutoShutdown state ( $<0.2 \mu \mathrm{~A}$ ) after power-up and between conversions. After detecting a rising edge on CNVST, the part powers up, sets DOUT low and enters track mode. After detecting a falling-edge on CNVST, the device enters hold mode and begins the conversion. A maximum of $3.7 \mu \mathrm{~s}$ later, the device completes conversion, enters shutdown and MSB is available at DOUT.

External Reference
An external reference is required for the MAX1086MAX1089. Use a $0.1 \mu \mathrm{~F}$ bypass capacitor for best performance. The reference input structure allows a voltage range of $+1 V$ to $V_{D D}+50 \mathrm{mV}$.


Figure 6. Unipolar Transfer Function

## Transfer Function

Figure 6 shows the unipolar transfer function for the MAX1086-MAX1089. Figure 7 shows the bipolar transfer function for the MAX1088/MAX1089. Code transitions occur halfway between successive-integer LSB values.

Connection to Standard Interfaces The MAX1086-MAX1089 feature a serial interface that is fully compatible with SPI, QSPI, and MICROWIRE. If a serial interface is available, establish the CPU's serial interface as a master, so that the CPU generates the serial clock for the ADCs. Select a clock frequency up to 8MHz.

How to Perform a Conversion

1) Use a general purpose I/O line on the CPU to hold CNVST low between conversions.
2) Drive CNVST high to acquire AIN1(MAX1086/ MAX1087) or unipolar mode (MAX1088/MAX1089). To acquire AIN2(MAX1086/MAX1087) or bipolar mode (MAX1088/MAX1089), drive CNVST low and high again.
3) Hold CNVST high for $1.4 \mu \mathrm{~s}$.
4) Drive CNVST low and wait approximately 3.7 Hs for conversion to complete. After $3.7 \mu \mathrm{~s}$, the MSB is available at DOUT.
5) Activate SCLK for a minimum of 12 rising clock edges. DOUT transitions on SCLK's falling edge


Figure 7. Bipolar Transfer Function

# 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN 

and is available in MSB-first format. Observe the SCLK to DOUT valid timing characteristic. Clock data into the $\mu \mathrm{P}$ on SCLK's rising-edge.

## SPI and MICROWIRE Interface

When using SPI interface (Figure 8a) or MICROWIRE (Figure 8a and 8b), set CPOL $=$ CPHA $=0$. Two 8 -bit readings are necessary to obtain the entire 10 -bit result from the ADC. DOUT data transitions on the serial clock's falling edge and is clocked into the $\mu \mathrm{P}$ on SCLK's rising edge. The first 8 -bit data stream contains the first 8 -bits of DOUT starting with the MSB. The second 8 -bit data stream contains the remaining two result bits ( $\mathrm{B} 1, \mathrm{BO}$ ) and two trailing sub-bits (S1, S0). DOUT then goes high impedance.

QSPI Interface Using the high-speed QSPI interface (Figure 9a) with CPOL $=0$ and CPHA $=0$, the MAX1086-MAX1089 support a maximum fsclk of 8 MHz . One 8 - to16-bit reading is necessary to obtain the entire 10 -bit result from the ADC. DOUT data transitions on the serial clock's falling edge and is clocked into the $\mu \mathrm{P}$ on


Figure 8a. SPI Connections

SCLK's rising edge. The first 10 bits are the data and the next two bits are sub-bits (S1, S0). DOUT then goes high impedance (Figure 9b).

## PIC16 and SSP Module and PIC1 7 Interface

The MAX1086-MAX1089 are compatible with a PIC16/PIC17 microcontroller ( $\mu \mathrm{C}$ ), using the synchronous serial port (SSP) module
To establish SPI communication, connect the controller as shown in Figure 10a and configure the PIC16/PIC17 as system master. This is done by initializing its synchronous serial port control register (SSPCON) and synchronous serial port status register (SSPSTAT) to the bit patterns shown in Tables 1 and 2.
In SPI mode, the PIC16/PIC17 $\mu$ Cs allow eight bits of data to be synchronously transmitted and received simultaneously. Two consecutive 8 -bit readings (Figure 10b) are necessary to obtain the entire 10 -bit result from the ADC. DOUT data transitions on the serial clock's falling edge and is clocked into the $\mu \mathrm{C}$ on SCLK's rising edge. The first 8-bit data stream contains


Figure 8b. MICROWIRE Connections

Table 1. Detailed SSPCON Register Content

| CONTROL BIT |  | $\begin{gathered} \hline \text { MAX1086-MAX1089 } \\ \text { SETTINGS } \end{gathered}$ | SYNCHRONOUS SERIAL PORT CONTROL REGISTER (SSPCON) |
| :---: | :---: | :---: | :---: |
| WCOL | Bit 7 | X | Write Collision Detection Bit |
| SSPOV | Bit 6 | X | Receive Overflow Detect Bit |
| SSPEN | Bit 5 | 1 | Synchronous Serial Port Enable Bit. <br> 0: Disables serial port and configures these pins as I/O port pins. <br> 1: Enables serial port and configures SCK, SDO and SCI pins as serial port pins. |
| CKP | Bit 4 | 0 | Clock Polarity Select Bit. CKP = 0 for SPI master mode selection. |
| SSPM3 | Bit 3 | 0 |  |
| SSPM2 | Bit 2 | 0 | Synchronous Serial Port Mode Select Bit. Sets SPI master mode and selects |
| SSPM1 | Bit 1 | 0 | fCLK = fosc / 16. |
| SSPM0 | Bit 0 | 1 |  |

$X=$ Don't care

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Figure 8c. SPI/MICROWIRE Interface Timing Sequence (CPOL $=C P H A=0)$
the first eight data bits starting with the MSB. The second 8-bit data stream contains the remaining bits, D1 through D0, and the two sub-bits S1 and S0.

Layout, Grounding, and Bypassing
For best performance, use printed circuit (PC) boards. Wire-wrap configurations are not recommended since the layout should ensure proper separation of analog

and digital traces. Do not run analog and digital lines parallel to each other, and do not lay out digital signal paths underneath the ADC package. Use separate analog and digital PC board ground sections with only one starpoint (Figure 11), connecting the two ground systems (analog and digital). For lowest-noise operation, ensure the ground return to the star ground's power supply is low impedance and as short as possible. Route digital signals far away from sensitive analog and reference inputs.
High-frequency noise in the power supply (VDD) may degrade the performance of the ADC's fast comparator. Bypass VDD to the star ground with a $0.1 \mu \mathrm{~F}$ capacitor, located as close as possible to the MAX1086-MAX1089s power supply pin. Minimize capacitor lead length for best supply-noise rejection. Add an attenuation resistor (5 5 ) if the power supply is extremely noisy.

Figure 9a. QSPI Connections
Table 2. Detailed SSPSTAT Register Content

| CONTROL BIT |  | MAX1086-MAX1089 <br> SETTINGS | SYNCHRONOUS SERIAL STATUS REGISTER (SSPSTAT) |
| :---: | :---: | :---: | :--- |
| SMP | Bit 7 | 0 | SPI Data Input Sample Phase. Input data is sampled at the middle of the data output <br> time. |
| CKE | Bit 6 | 1 | SPI Clock Edge Select Bit. Data will be transmitted on the rising edge of the serial clock. |
| D/A | Bit 5 | X | Data Address Bit |
| P | Bit 4 | X | Stop Bit |
| S | Bit 3 | X | Start Bit |
| R/W | Bit 2 | X | Read/Write Bit Information |
| UA | Bit 1 | X | Update Address |
| BF | Bit 0 | X | Buffer Full Status Bit |

[^0]
## 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN



Figure 9b. QSPI Interface Timing Sequence ( $C P O L=C P H A=0$ )


Figure 10a. SPI Interface Connection for a PIC16/PIC17 Controller

## Definitions

Integral Nonlinearity
Integral nonlinearity ( INL ) is the deviation of the values on an actual transfer function from a straight line. This straight line can be either a best-straight-line fit or a line drawn between the endpoints of the transfer function, once offset and gain errors have been nullified. The static linearity parameters for the MAX1086-MAX1089 are measured using the endpoint method.

Differential Nonlinearity
Differential nonlinearity (DNL) is the difference between an actual step-width and the ideal value of 1LSB. A DNL error specification of less than 1LSB guarantees no missing codes and a monotonic transfer function.


Figure 10b. SPI Interface Timing with PIC16/PIC17 in Master Mode (CKE =1, CKP = 0, SMP = 0, SSPM3-SSPM0 = 0001)

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Figure 11. Power-Supply and Grounding Connections

## Aperture Definitions

Aperture jitter (tAJ) is the sample-to-sample variation in the time between the samples. Aperture delay (tad) is the time between the rising edge of the sampling clock and the instant when an actual sample is taken.

## Signal-to-Noise Ratio

For a waveform perfectly reconstructed from digital samples, signal-to-noise ratio (SNR) is the ratio of full-scale analog input (RMS value) to the RMS quantization error (residual error). The ideal, theoretical minimum analog-todigital noise is caused by quantization error only and results directly from the ADC's resolution ( N -bits):

$$
\mathrm{SNR}=(6.02 \times \mathrm{N}+1.76) \mathrm{dB}
$$

In reality, there are other noise sources besides quantization noise: thermal noise, reference noise, clock jitter, etc. SNR is computed by taking the ratio of the RMS signal to the RMS noise, which includes all spectral components minus the fundamental, the first five harmonics, and the DC offset.

## Signal-to-Noise Plus Distortion

Signal-to-noise plus distortion (SINAD) is the ratio of the fundamental input frequency's RMS amplitude to RMS equivalent of all other ADC output signals.

$$
\text { SINAD }(d B)=20 \times \log (\text { SignalRMS } / \text { NoisermS })
$$

## Effective Number of Bits

Effective number of bits (ENOB) indicates the global accuracy of an ADC at a specific input frequency and sampling rate. An ideal ADC's error consists of quantization noise only. With an input range equal to the fullscale range of the ADC, calculate the effective number of bits as follows:

$$
\text { ENOB }=(\text { SINAD }-1.76) / 6.02
$$

## Total Harmonic Distortion

Total harmonic distortion (THD) is the ratio of the RMS sum of the first five harmonics of the input signal to the fundamental itself. This is expressed as:

$$
T H D=20 \cdot \log \left(\sqrt{\left(V_{2}^{2}+V_{3}^{2}+V_{4}^{2}+V_{5}^{2}\right)} / V_{1}\right)
$$

where $V_{1}$ is the fundamental amplitude, and $V_{2}$ through $V_{5}$ are the amplitudes of the 2nd- through 5th-order harmonics.

Spurious-Free Dynamic Range
Spurious-free dynamic range (SFDR) is the ratio of RMS amplitude of the fundamental (maximum signal component) to the RMS value of the next largest distortion component.

Chip Information
PROCESS: BiCMOS

## Package Information

For the latest package outline information and land patterns, go to www.maxim-ic.com/packages. Note that a "+", "\#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

| PACKAGE <br> TYPE | PACKAGE <br> CODE | OUTLINE NO. | LAND <br> PATTERN NO. |
| :---: | :---: | :---: | :---: |
| 8 SOT 23 | K8F-4 | $\underline{\mathbf{2 1 - 0 0 7 8}}$ | $\underline{\underline{90-0176}}$ |
| 8 TDFN | $\mathrm{T} 833+2$ | $\underline{\mathbf{2 1 - 0 1 3 7}}$ | $\underline{\underline{90-0059}}$ |

## 150ksps, 10-Bit, 2-Channel Single-Ended, and 1-Channel True-Differential ADCs in SOT23 and TDFN

| Revision History |  |  |  |
| :---: | :---: | :--- | :---: |
| REVISION <br> NUMBER | REVISION <br> DATE | DESCRIPTION | PAGEs CHANGED |
| 1 | $8 / 07$ | Added TDFN packages | $1,2,7,15,16,17$ |
| 2 | $6 / 08$ | Added ETA packaging | 1,7 |
| 3 | $8 / 10$ | Added lead-free variants and soldering temperature | 1,2 |

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ADS7955QDBTRQ1 ADS7807UB ADS7805UB ADS1220IPWR MCP3426A0-E/MS MCP3422A0-E/MC AD9220AR MAX11212AEUB+
TLV1570CDW TLC3574IDWR TLC1542IDWR TLC0838CDWR AD7914BRUZ-REEL7 AD977ABRZ ADC12130CIWM/NOPB
MCP3426A1-EMC MCP3426A0-EMC AD7192BRUZ-REEL AD7193BRUZ-REEL


[^0]:    $X=$ Don't care

